

## **ELECTRICAL SPECIFICATIONS**

#### Absolute Maximum Ratings\*

Ambient Temperature under Bias0°C to +70°C
Storage Temperature65°C to +150°C
Voltage on Any Pin with Respect to Ground 1.0V to +7.0V
Package Power Dissipation

NOTICE: This data sheet contains preliminary information on new products in production. The specifications are subject to change without notice. Verify with your local Intel Sales office that you have the latest data sheet before finalizing a design.

\*WARNING: Stressing the device beyond the "Absolute Maximum Ratings" may cause permanent damage. These are stress ratings only. Operation beyond the "Operating Conditions" is not recommended and extended exposure beyond the "Operating Conditions" may affect device reliability.

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DC SPECIFICATIONS  $T_A = 0$ °C to +70°C,  $V_{CC} = 5V \pm 10$ %

Symbol	Parameter	Min	Max	Units	Test Conditions
V <sub>IL</sub>	Input Low Voltage (Except X1)	-0.5	0.2 V <sub>CC</sub> - 0.3	<b>v</b>	
V <sub>IL1</sub>	Clock Input Low Voltage (X1)	-0.5	0.6	<b>v</b>	
V <sub>IH</sub>	Input High Voltage (All except X1 and RES)	0.2 V <sub>CC</sub> + 0.9	V <sub>CC</sub> + 0.5		
V <sub>IH1</sub>	Input High Voltage (RES)	3.0	V <sub>CC</sub> + 0.5	٧	
V <sub>iH2</sub>	Clock Input High Voltage (X1)	3.9	V <sub>CC</sub> + 0.5	>	
V <sub>OL</sub>	Output Low Voltage		0.45	\ \	I <sub>OL</sub> = 2.5 mA (S0, 1, 2) I <sub>OL</sub> = 2.0 mA (others)
V <sub>OH</sub>	Output High Voltage	2.4	V <sub>CC</sub>	٧	I <sub>OH</sub> = -2.4 mA @ 2.4V (4)
		V <sub>CC</sub> - 0.5	V <sub>CC</sub>	٧	$I_{OH} = -200 \mu\text{A} \otimes V_{CC} - 0.5(4)$
Icc	Power Supply Current		100	mA	@ 25 MHz, 0°C V <sub>CC</sub> = 5.5V <sup>(3)</sup>
			90	mA	@ 20 MHz, 0°C V <sub>CC</sub> = 5.5V(3)
			62.5	mA	@ 12 MHz, 0°C V <sub>CC</sub> = 5.5V (3)
			100	μА	@ DC 0°C V <sub>CC</sub> = 5.5V
l <sub>Ll</sub>	Input Leakage Current		±10	μΑ	@ 0.5 MHz, 0.45V ≤ V <sub>IN</sub> ≤ V <sub>CC</sub>
ILO	Output Leakage Current		± 10	μА	@ 0.5 MHz, $0.45V \le V_{OUT} \le V_{CC}^{(1)}$
V <sub>CLO</sub>	Clock Output Low		0.45	٧	I <sub>CLO</sub> = 4.0 mA

Preliminary



## DC SPECIFICATIONS (Continued) $T_A = 0^{\circ}C$ to $+70^{\circ}C$ , $V_{CC} = 5V \pm 10\%$

Symbol	Parameter	Min	Max	Units	Test Conditions
V <sub>CHO</sub>	Clock Output High	V <sub>CC</sub> - 0.5		٧	I <sub>CHO</sub> = ~500 μA
C <sub>IN</sub>	Input Capacitance		10	. pF	@ 1 MHz <sup>(2)</sup>
C <sub>IO</sub>	Output or I/O Capacitance		20	pF	@ 1 MHz(2)

1. Pins being floated during HOLD or by invoking the ONCE Mode.

2. Characterization conditions are a) Frequency = 1 MHz; b) Unmeasured pins at GND; c) V<sub>IN</sub> at + 5.0V or 0.45V. This parameter is not tested.

3. Current is measured with the device in RESET with X1 and X2 driven and all other non-power pins open.
4. RD/QSMD, UCS, UCS, MCSO/PEREQ, MCS1/ERROR and TEST/BUSY pins have internal pullup devices. Loading some of these pins above I<sub>OH</sub> = -200 µA can cause the processor to go into alternative modes of operation. See the section on Local Bus Controller and Reset for details.

# **Power Supply Current**

Current is linearly proportional to clock frequency and is measured with the device in RESET with X1 and X2 driven and all other non-power pins open.

Maximum current is given by  $I_{CC} = 5 \text{ mA} \times \text{freq}$ .  $(MHz) + I_{QL}$ 

IOL is the quiescent leakage current when the clock is static.  $I_{QL}$  is typically less than 100  $\mu$ A.

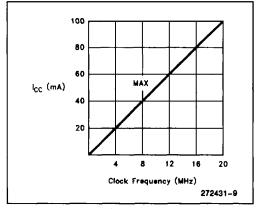


Figure 5. I<sub>CC</sub> vs Frequency